

Notice of References Cited

Application/Control No.

10/675,632

Applicant(s)/Patent Under
Reexamination
OSAWA, IKUO

Examiner

Jean W. Désir

Art Unit

2622

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,562,424 A	02-1971	Legler, Ernst	348/629
*	B	US-3,995,108 A	11-1976	Morrison, Eric Fraser	348/627
*	C	US-4,245,238 A	01-1981	Fuhrer, Jack S.	348/628
*	D	US-4,336,552 A	06-1982	Tanaka, Sadaaki	348/606
*	E	US-4,647,960 A	03-1987	Miura et al.	348/628
*	F	US-4,882,628 A	11-1989	Sugimori et al.	348/628
*	G	US-5,006,927 A	04-1991	Creed et al.	348/665
*	H	US-5,170,248 A	12-1992	Min, Byung-Min	348/628
*	I	US-5,363,140 A	11-1994	Isomoto et al.	348/445
*	J	US-5,446,503 A	08-1995	Sproule, Patrick	348/628
*	K	US-5,587,745 A	12-1996	Griepentrog et al.	348/626
*	L	US-5,940,141 A	08-1999	Faroudja et al.	348/628
*	M	US-6,424,383 B1	07-2002	Terai et al.	348/628

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,360,830 A	11-1982	Poetsch et al.	348/628
*	B	US-4,365,266 A	12-1982	Lagoni, William A.	348/628
*	C	US-4,802,010 A	01-1989	Skinner et al.	348/625
*	D	US-4,916,538 A	04-1990	Carver et al.	348/625
*	E	US-5,268,758 A	12-1993	Nakayama et al.	348/628
*	F	US-5,268,759 A	12-1993	Kishimoto et al.	348/606
*	G	US-5,396,157 A	03-1995	Hackett et al.	315/394
*	H	US-5,467,145 A	11-1995	Limberg, Allen L.	348/628
*	I	US-5,581,306 A	12-1996	Ohara, Kazuhiro	348/625
*	J	US-6,034,742 A	03-2000	Kimoto et al.	348/625
*	K	US-6,330,038 B1	12-2001	Johnson, Drew S.	348/625
*	L	US-6,377,313 B1	04-2002	Yang et al.	348/630
*	M	US-6,392,714 B1	05-2002	Steinberg et al.	348/666

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,403,246 A	09-1983	Thornberry, Gerald E.	348/628
*	B	US-4,612,567 A	09-1986	Pritchard, Dalton H.	348/451
*	C	US-4,658,295 A	04-1987	Umezawa, Toshimitsu	348/625
*	D	US-4,962,419 A	10-1990	Hibbard et al.	348/627
*	E	US-5,121,209 A	06-1992	Smith et al.	348/625
*	F	US-5,428,398 A	06-1995	Faroudja, Yves C.	348/452
*	G	US-5,430,499 A	07-1995	Asada et al.	348/628
*	H	US-5,521,636 A	05-1996	Nakayama et al.	348/222.1
*	I	US-5,561,473 A	10-1996	Saionji et al.	348/628
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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